









BQ25172

ZHCSPT0 - JUNE 2022

适用于1至6节镍氢电池的800mA线性电池充电器 BQ25172:

1 特性

- 可承受高达 30V 的输入电压
- 自动睡眠模式,可降低功耗
 - 350nA 电池泄漏电流
 - 禁用充电时,输入泄漏电流为 85µA
- 通过间歇性充电功能支持 1 节至 6 节镍氢电池
- 操作可使用外部电阻器进行编程
 - VSET 用于设置镍氢电池节数(1节至6节)
 - 用于设置 10mA 至 800mA 充电电流的 ISET
 - TMR 用于设置充电安全计时器时间 (4 小时至 22 小时)
- 高精度
 - 充电电压精度为 ±0.5%
 - 充电电流精度为 ±10%
- 充电特性
 - NTC 热敏电阻输入用于监控电池温度
 - 禁用低温和高温充电
 - V_{OUT OVP} 在低温下降低
 - TS 引脚用于充电功能控制
 - 用于状态和故障指示的开漏输出
- 集成故障保护
 - 18V 输入过压保护
 - 基于 VSET 的输出过压保护
 - 1000mA 过流保护
 - 125°C 热调节;150°C 热关断保护
 - OUT 短路保护
 - VSET、ISET、TMR 引脚短路/开路保护

2 应用

- 车队管理、资产跟踪
- 气体检测仪
- 电子销售点 (ePOS)
- 美容美发
- 电动牙刷
- 脉搏血氧仪
- 血糖监控
- 红外温度计

3 说明

BQ25172 是一款集成 800mA 线性充电器,适用于工 业和医疗应用的 1 节至 6 节镍氢电池。 该器件具有为 电池充电的单电源输出。只要安全计时器期间内平均系 统负载不会妨碍电池充满电,就可以使系统负载与电池 并联。当系统负载与电池并联时,充电电流会由系统和 电池共享。

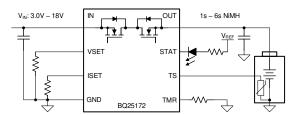
该器件仅在恒流模式下为镍氢电池充电,并在可编程计 时器到期或电池电压超过 Vour ovp 阈值时终止充电周 期。 在所有充电阶段,内部控制环路监控 IC 结温,并 在其超过内部温度阈值 T_{RFG} 时降低充电电流。

充电器功率级和充电电流感测功能均完全集成。该充电 器具有高精度电流、充电状态显示和基于计时器的充电 终止功能。可通过外部电阻器对串联电池数、充电电流 和充电计时器进行编程。间歇充电允许镍氢电池在其电 压低于再充电阈值时自动再充电,以缩短计时器持续时

器件信息

器件型号	封装 ⁽¹⁾	封装尺寸(标称值)
BQ25172	WSON (8)	2.0mm x 2.0mm

如需了解所有可用封装,请参阅数据表末尾的可订购产品附



简化版原理图



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4 Revision History 注:以前版本的页码可能与当前版本的页码不同

DATE	REVISION	NOTES
June 2022	*	Initial Release



5 Pin Configuration and Functions

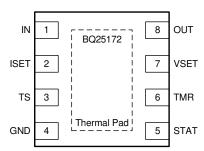


图 5-1. DSG Package WSON 8-Pin Top View

表 5-1. Pin Functions

P	IN	I/O	DESCRIPTION
NAME	NUMBER	"0	DESCRIPTION
IN	1	Р	Input power, connected to external DC supply. Bypass IN with a \geqslant 1- \upmu F capacitor to GND, placed close to the IC.
ISET	2	I	Programs the device charge current. External resistor from ISET to GND defines charge current value. Expected range is 30 k Ω (10 mA) to 375 Ω (800 mA). ICHG = K_{ISET} / R_{ISET} .
TS	3	I	Temperature qualification voltage input. Connect a negative temperature coefficient (NTC) thermistor directly from TS to GND (AT103-2 recommended). Charge suspends when the TS pin voltage is out of range. VOUT_OVP is reduced in cool region. If TS function is not needed, connect an external 10-k Ω resistor from this pin to GND. Pulling V _{TS} < V _{TS_ENZ} disables the charger.
GND	4	-	Ground pin
STAT	5	0	Open drain charge status indication output. Connect to the pullup rail via a 10-k Ω resistor. LOW indicates charge in progress. HIGH indicates charge complete or charge disabled. When a fault condition is detected, the STAT pin blinks at 1 Hz.
TMR	6	I	Connect to a pulldown resistor to program charge safety timer duration. Valid resistor range is 3.6 k Ω to 36 k Ω . Refer to \ddagger 7.3.1.2.
VSET	7	I	Programs the number of series NiMH cells. Valid resistor range is 3.6 k Ω to 62 k Ω . Recommend using a ±1% tolerance resistor with <200 ppm/°C temperature coefficient. Refer to \dagger 7.3.1.3.
OUT	8	Р	Battery connection. System load may be connected in parallel to the battery. Bypass OUT with a \geqslant 1- μ F capacitor to GND, placed close to the IC.
Thermal Pad	_	_	Exposed pad beneath the IC for heat dissipation. Solder thermal pad to the board with vias connecting to solid GND plane.



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
Voltage	IN	- 0.3	30	V
Voltage	OUT	- 0.3	13	V
Voltage	ISET, STAT, TMR, TS, VSET	- 0.3	5.5	V
Output Sink Current	STAT		5	mA
Junction temperature, T _J		- 40	150	°C
Storage temperature, T _{stg}		- 65	150	°C

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If briefly operating outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.

6.2 ESD Ratings

				UNIT
V	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/ JEDEC JS-001, all pins ⁽¹⁾	±2500	V
V _(ESD)	Liectiostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	±1500	V

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V _{IN}	Input voltage	3.0		18	V
V _{OUT}	Output voltage			10.5	V
I _{OUT}	Output current			0.8	Α
TJ	Junction temperature	- 40		125	°C
C _{IN}	IN capacitor	1			μF
C _{OUT}	OUT capacitor	1			μF
R _{TMR}	TMR resistor	3.6		36	kΩ
R _{VSET}	VSET resistor	3.6		62	kΩ
R _{TMR_VSET_TOL}	Tolerance for TMR, and VSET resistors	-1		1	%
R _{TMR_VSET_TEMPCO}	Temperature coefficient for TMR, and VSET resistors			200	ppm/℃
R _{ISET}	ISET resistor	0.375		30	k Ω
R _{TS}	TS thermistor resistor (recommend 103AT-2)		10		k Ω

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6.4 Thermal Information

		BQ25172	
	THERMAL METRIC ⁽¹⁾	DSG(WSON)	UNIT
		8 PINS	
R ₀ JA	Junction-to-ambient thermal resistance (JEDEC ⁽¹⁾)	75.2	°C/W
R _{θ JC(top)}	Junction-to-case (top) thermal resistance	93.4	°C/W
R ₀ JB	Junction-to-board thermal resistance	41.8	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	3.8	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	41.7	°C/W
R ₀ JC(bot)	Junction-to-case (bottom) thermal resistance	17.0	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



6.5 Electrical Characteristics

 $3.0 \text{V} < \text{V}_{\text{IN}} < 18 \text{V}$ and $\text{V}_{\text{IN}} > \text{V}_{\text{OUT}} + \text{V}_{\text{SLEEP}}$, $\text{T}_{\text{J}} = -40 ^{\circ} \text{C}$ to +125 $^{\circ} \text{C}$, and $\text{T}_{\text{J}} = 25 ^{\circ} \text{C}$ for typical values (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
QUIESCENT C	URRENTS					
1	Ouisseent output ourrent (OLIT)	OUT= 4.2V, IN floating or IN = 0V - 5V, Charge Disabled, T _J = 25 °C		0.350	0.6	μA
I _{Q_OUT}	Quiescent output current (OUT)	OUT= 4.2V, IN floating or IN = 0V - 5V, Charge Disabled, T _J < 105 °C		0.350	0.8	μA
	Outcoant output outront (OLIT)	OUT = 8.4V, IN floating or IN = 0V - 14V, Charge Disabled, T _J = 25 °C		0.8	1.2	μA
I _{Q_OUT}	Quiescent output current (OUT)	OUT = 8.4V, IN floating or IN = 0V - 14V, Charge Disabled, T _J < 105 °C		0.8	1.5	μA
I _{SD_IN_TS}	Shutdown input current (IN) with charge disabled via TS pin	IN = 5V, Charge Disabled (V _{TS} < V _{TS_ENZ}), no battery		80	110	μA
I _{STANDBY_IN}	Standby input current (IN) with charge terminated	IN = 5V, Charge Enabled, charge terminated		190		μA
I _{STANDBY_IN}	Standby input current (IN) with charge terminated	IN = 14V, Charge Enabled, charge terminated		230		μA
I _{Q_IN}	Quiescent input current (IN)	IN = 5V, OUT = 3.8V, Charge Enabled, ICHG = 0A		0.45	0.6	mA
I _{Q_IN}	Quiescent input current (IN)	IN = 14V, OUT = 7.6V, Charge Enabled, ICHG = 0A		0.45	0.6	mA
INPUT						
V _{IN_OP}	IN operating range		3.0		18	V
V _{IN_LOWV}	IN voltage to start charging	IN rising	3.05	3.09	3.15	V
V _{IN_LOWV}	IN voltage to stop charging	IN falling	2.80	2.95	3.10	V
V _{SLEEPZ}	Exit sleep mode threshold	IN rising, V _{IN} - V _{OUT} , OUT = 4V	95	135	175	mV
V _{SLEEP}	Sleep mode threshold hysteresis	IN falling, V _{IN} - V _{OUT} , OUT = 4V		80		mV
V _{IN_OV}	VIN overvoltage rising threshold	IN rising	18.1	18.4	18.7	V
V _{IN_OVZ}	VIN overvoltage falling threshold	IN falling		18.2		V
CONFIGURATION	ON PINS SHORT/OPEN PROTECTION					
R _{ISET_SHORT}	Resistor value considered short	R_{ISET} below this at startup, charger does not initiate charge, power cycle or TS toggle to reset			350	Ω
R _{VSET_SHORT}	Resistor value considered short	R _{VSET} below this at startup, charger does not initiate charge, power cycle or toggle to reset			2.8	kΩ
R _{VSET_OPEN}	Resistor value considered open	R _{VSET} above this at startup, charger does not initiate charge, power cycle or toggle to reset	80			kΩ
R _{TMR_SHORT}	Resistor value considered short	R _{TMR} below this at startup, charger latches off, power cycle or TS toggle to reset			2.8	kΩ
R _{TMR_OPEN}	Resistor value considered open	R _{TMR} above this at startup, charger latches off, power cycle or TS toggle to reset	45			kΩ
BATTERY CHA	RGER					
I _{CHG_RANGE}	Typical charge current regulation range		10		800	mA
K _{ISET}	Charge current setting factor, I _{CHG} = K _{ISET} / R _{ISET}	10mA < ICHG < 800mA	270	300	330	ΑΩ
		R_{ISET} = 375 Ω , OUT = 3.8V	720	800	880	mA
	Charge current agains	R_{ISET} = 600 Ω , OUT = 3.8V	450	500	550	mA
I _{CHG_ACC}	Charge current accuracy	R _{ISET} = 3.0k Ω , OUT = 3.8V	90	100	110	mA
		R _{ISET} = 30k Ω , OUT = 3.8V	9	10	11	mA



6.5 Electrical Characteristics (continued)

 $3.0 \text{V} < \text{V}_{\text{IN}} < 18 \text{V} \text{ and } \text{V}_{\text{IN}} > \text{V}_{\text{OUT}} + \text{V}_{\text{SLEEP}}, \text{T}_{\text{J}} = -40 ^{\circ}\text{C to } +125 ^{\circ}\text{C}, \text{ and } \text{T}_{\text{J}} = 25 ^{\circ}\text{C for typical values (unless otherwise noted)}$

O.O. VIIIN VIOL	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{RECHG}	Battery recharge threshold, per cell	OUT falling, VSET configured for 2-cell	1.305	1.330	1.355	V
	0, , , , , , , , , , , , , , , , , , ,	IOUT = 400mA, T _J = 25°C		845	1000	mΩ
R _{ON}	Charging path FET on-resistance	IOUT = 400mA, T _J = -40 - 125°C		845	1450	mΩ
BATTERY CHAR	GER PROTECTION					
V _{OUT_OVP}	OUT overvoltage rising threshold, per cell	VOUT rising, TS normal	1.65	1.70	1.75	V
V _{OUT_OVP}	OUT overvoltage falling threshold, per cell	VOUT falling, TS normal	1.40	1.45	1.50	V
V _{OUT_OVP_TSCOOL}	OUT overvoltage rising threshold, per cell	VOUT rising, TS in cool range	1.45	1.50	1.55	V
V _{OUT_OVP_TSCOOL}	OUT overvoltage falling threshold, per cell	VOUT falling, TS in cool range	1.30	1.35	1.40	٧
I _{OUT_OCP}	Output current limit threshold	IOUT rising	0.9	1	1.1	Α
TEMPERATURE	REGULATION AND TEMPERATURE S	HUTDOWN				
T _{REG}	Typical junction temperature regulation			125		°C
т	Thermal shutdown rising threshold	Temperature increasing		150		°C
T _{SHUT}	Thermal shutdown falling threshold	Temperature decreasing		135		°C
BATTERY-PACK	NTC MONITOR					
I _{TS_BIAS}	TS nominal bias current		36.5	38	39.5	μA
V	Cold temperature threshold	TS pin voltage rising (approx. 0°C)	0.99	1.04	1.09	V
V _{COLD}	Cold temperature exit threshold	TS pin voltage falling (approx. 4°C)	0.83	0.88	0.93	V
V	Cool temperature threshold; V _{OUT_OVP} reduced	TS pin voltage rising (approx. 10°C)	650	680	710	mV
V_{COOL}	Cool temperature exit threshold; V _{OUT_OVP} returns to normal	TS pin voltage falling (approx. 13°C)	580	610	640	mV
V	Hot temperature threshold	TS pin voltage falling (approx. 45°C)	176	188	200	mV
V_{HOT}	Hot temperature exit threshold	TS pin voltage rising (approx. 40°C)	208	220	232	mV
V _{TS_ENZ}	Charge Disable threshold. Crossing this threshold shall shutdown IC	TS pin voltage falling	40	50	60	mV
V _{TS_EN}	Charge Enable threshold. Crossing this threshold shall restart IC operation	TS pin voltage rising	65	75	85	mV
V _{TS_CLAMP}	TS maximum voltage clamp	TS pin open-circuit (float)	2.3	2.6	2.9	V
LOGIC OUTPUT	PIN (STAT)					
V _{OL}	Output low threshold level	Sink current = 5mA			0.4	V
I _{OUT_BIAS}	High-level leakage current	Pull up rail 3.3V			1	μA

6.6 Timing Requirements

		MIN	NOM	MAX	UNIT
BATTERY CHARGER					
t _{TS_DUTY_ON}	TS turn-on time during TS duty cycle mode		100		ms
t _{TS_DUTY_OFF}	TS turn-off time during TS duty cycle mode		2		s
tout_ocp_dgl	Deglitch time for I _{OUT_OCP} , IOUT rising		100		μs
t _{SAFETY}	Charge safety timer accuracy, R _{TMR} = 18k Ω	9.5	10	10.5	hr
t _{INTERMITTENT}	Commercial Intermittent charge safety timer (NiMH), as percentage of t _{SAFETY}		20		%

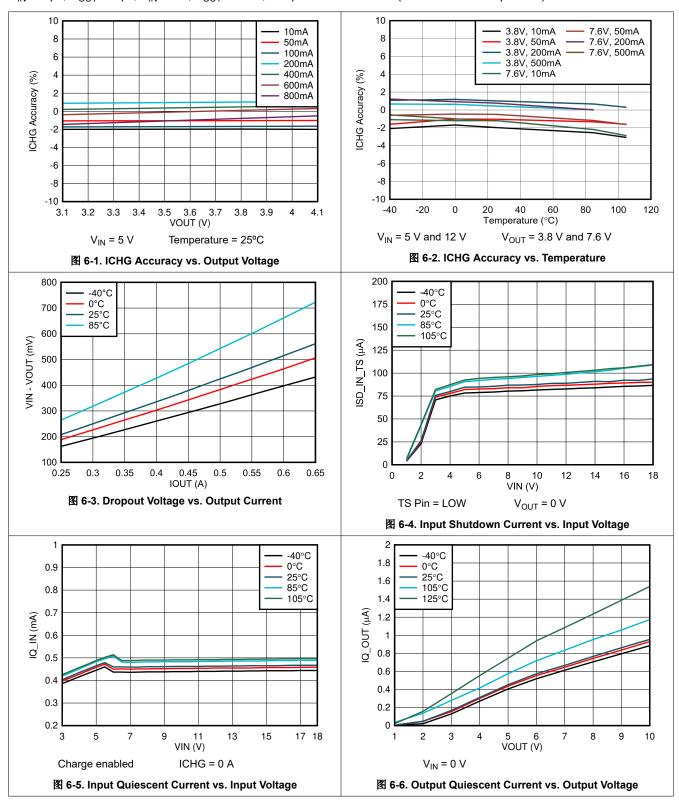
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6.7 Typical Characteristics

 C_{IN} = 1 μ F, C_{OUT} = 1 μ F, V_{IN} = 5 V, V_{OUT} = 3.8 V, Temperature = Ambient (unless otherwise specified)





7 Detailed Description

7.1 Overview

The BQ25172 is an integrated 800-mA linear charger for 1-cell to 6-cell NiMH battery applications. The device has a single power output that charges the battery. When the system load is placed in parallel with the battery, the input current is shared between the system and the battery.

The device charges a NiMH battery in constant current mode only and terminates the charge cycle when the programmable timer, t_{SAFETY} , expires or the battery voltage exceeds the V_{OUT_OVP} threshold. An optional intermittent charging phase can be programmed to automatically recharge the NiMH battery for a reduced timer duration once its voltage falls below V_{RECHG} .

The charger includes flexibility in programming of the charge current, charge safety timer duration, and series cell-count. This charger is designed to work with a standard USB connection or dedicated charging adapter (DC output).

The charger also comes with a full set of safety features: battery temperature monitoring, overvoltage protection, charge safety timer, and configuration pin (VSET, ISET, TMR) short and open protection. Upon application of a valid input power source, the configuration pins are checked for short and open circuits. All of these features and more are described in detail in the following sections.

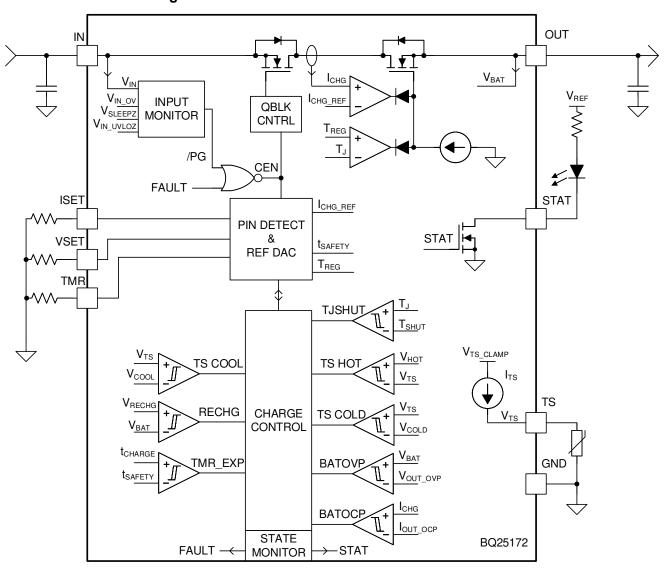
The charger is designed for a single path from the input to the output to charge the battery. Once the input adapter has been connected, the charge current is applied and the safety timer is started. The charge current is programmed using the ISET pin. The safety timer is programmed by the TMR pin.

Power dissipation in the IC is greatest at high charge currents and low battery voltages. If the IC temperature reaches T_{REG}, the IC enters thermal regulation, slows the timer clock by half, and reduces the charge current as needed to keep the temperature from rising any further.

Further details are described in † 7.3.



7.2 Functional Block Diagram





7.3 Feature Description

7.3.1 Device Power Up from Input Source

When an input source is plugged in and charge is enabled ($V_{TS} > V_{TS_EN}$), the device checks the input source voltage to turn on all the bias circuits. It detects and sets the charge current, safety timer length, and series cell-count before the linear regulator is started. The power-up sequence from input source is as listed:

- 1. ISET pin detection
- 2. TMR pin detection to select charge timer
- 3. VSET pin detection to select battery stack configuration
- 4. Charger power up

7.3.1.1 ISET Pin Detection

After a valid VIN is plugged in and $V_{TS} > V_{TS_EN}$, the device checks the resistor on the ISET pin for a short circuit ($R_{ISET} < R_{ISET_SHORT}$). If a short condition is detected, the charger remains in the FAULT state until the input or TS pin is toggled. If the ISET pin is open-circuit, the charger proceeds through pin detection and starts the charger with no charge current. The ISET pin is monitored while charging and changes in R_{ISET} while the charger is operating immediately translates to changes in charge current.

An external pulldown resistor (±1% or better is recommended to minimize charge current error) from the ISET pin to GND sets the charge current as:

$$I_{CHG} = \frac{K_{ISET}}{R_{ISET}}$$

(1)

where:

- I_{CHG} is the desired charge current
- · K_{ISET} is a gain factor found in the electrical characteristics
- R_{ISET} is the pulldown resistor from the ISET pin to GND

For charge currents below 50 mA, an extra RC circuit is recommended on ISET to achieve a more stable current signal. For greater accuracy at lower currents, part of the current-sensing FET is disabled to give better resolution.

7.3.1.2 TMR Pin Detection

The TMR pin is used to program the safety timer using a $\pm 1\%$ pulldown resistor. The available pulldown resistors and corresponding timer lengths are listed in the following table.

表 7-1. TMR Pin Resistor Value Table

RESISTOR	CHARGE TIMER (HR)
> 45 k Ω	No charge (open-circuit)
36 k Ω	4 hr
27 kΩ	6 hr
24 k Ω	8 hr
18 k Ω	10 hr
15 k Ω	12 hr
11 kΩ	14 hr
8.2 k Ω	16 hr
6.2 k Ω	18 hr
4.7 kΩ	20 hr

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表 7-1. TMR Pin Resistor Value Table (continued)

RESISTOR	CHARGE TIMER (HR)			
3.6 kΩ	22 hr			
< 3.0 k Ω	No charge (short-circuit)			

If either a short- or open-circuit condition is detected, the charger stops operation and remains in the FAULT state until the input or TS pin is toggled.

Once a value has been detected, it is latched in and the pin is not continuously monitored during operation. A change in this pin is not acknowledged by the IC until the input supply or TS pin is toggled.

7.3.1.3 VSET Pin Detection

The VSET pin is used to program the device cell configuration using a ±1% pulldown resistor. The available pulldown resistors and corresponding cell configurations are listed in the following table.

衣 7-2. VSET PIN RESISTOR VAIUE TABLE						
RESISTOR	CELL COUNT					
> 80 Ω	No charge (open-circuit)					
62 k Ω	1-cell					
47 k Ω	1-cell + intermittent charge					
36 k Ω	2-cell					
27 k Ω	2-cell + intermittent charge					
24 k Ω	3-cell					
18 k Ω	3-cell + intermittent charge					
15 k Ω	4-cell					
11 k Ω	4-cell + intermittent charge					
8.2 kΩ	5-cell					
6.2 kΩ	5-cell + intermittent charge					
4.7 kΩ	6-cell					
3.6 kΩ	6-cell + intermittent charge					
< 3.0 kΩ	No charge (short-circuit)					

表 7-2. VSET Pin Resistor Value Table

If either a short- or open-circuit condition is detected, the charger stops operation and remains in the FAULT state until the input or TS pin is toggled.

Once a valid resistor value has been detected, the corresponding cell configuration is latched in and the pin is not continuously monitored during operation. A change in this pin is not acknowledged by the IC until the input supply or TS pin is toggled.

7.3.1.4 Charger Power Up

After ISET, TMR, and VSET pin resistor values have been validated, the device proceeds to enable the charger. For more info see \ddagger 7.3.2.1.

7.3.2 Battery Charging Features

When charge is enabled ($V_{TS} > V_{TS_EN}$), the device automatically completes a charging cycle according to the settings on the ISET, TMR, and VSET pins. Charging is terminated when the charge safety timer expires or battery voltage exceeds $V_{OUT\ OVP}$.

7.3.2.1 NiMH Battery Charging Profile

The device charges NiMH batteries in constant current mode only. The charge current programmed by ISET is the only current applied over the charging cycle, as shown in 🖺 7-1. The charge termination method for the

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device is timer-based. The charge safety timer, t_{SAFETY}, sets the charging duration. Programming the charge safety timer is done with a pulldown resistor on the TMR pin.

Intermittent charging is designed to replenish the natural self-discharge of NiMH cells by restarting a short charge cycle (20% of t_{SAFETY}) when the output voltage falls below the V_{RECHG} threshold. If the intermittent charging function is disabled and a full charge cycle has been completed (safety timer expired with V_{OUT} above V_{RECHG}), the device does not start a new charge cycle automatically and requires input supply or TS pin toggle to initiate a new charge cycle.

If battery voltage is above V_{RECHG} at power up, the battery is considered full and the device does not charge. Once the battery voltage falls below V_{RECHG} , the device automatically begins charging. If the intermittent charging function is disabled, a single charge cycle is initiated with the safety timer duration programmed by the TMR pin. If intermittent charging is enabled, an intermittent charge cycle is initiated for 20% of the TMR programmed value.

When the charge timer (full-length or intermittent) expires, the battery voltage is checked again. If the battery voltage is below V_{RECHG} , a fault is reported through the STAT pin and further charging is prevented. If the charge timer expires with V_{OUT} above V_{RECHG} , the STAT pin indicates charge completed. In the case where the TS fault is within the cool threshold, V_{OUT} over is automatically reduced to V_{OUT} over V_{OUT} ove

If the charger is in thermal regulation during charging, the actual charging current will be less than the programmed value. Termination by timer is still enabled, but the charging safety timer is counted at half the clock rate. For more information, refer to $\ddagger 7.3.2.2$.

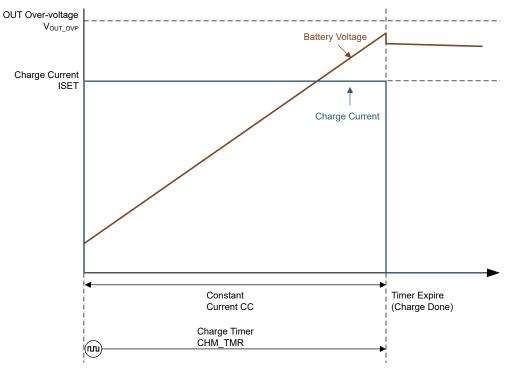


图 7-1. NiMH Battery Charging Profile with Intermittent Charging Disabled



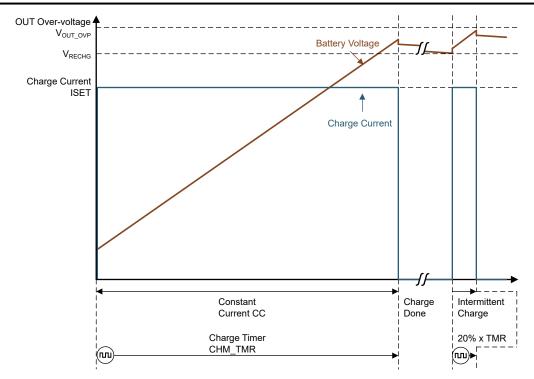


图 7-2. NiMH Battery Charging Profile with Intermittent Charging Enabled

7.3.2.2 Charging Safety Timers

The device has built-in safety timers to prevent an extended charging cycle due to abnormal battery conditions. When the safety timer expires, the charge cycle ends.

During thermal regulation, the safety timer counts at half the clock rate as the actual charge current is likely to be below the ISET setting. For example, if the charger is in thermal regulation throughout the whole charging cycle and the safety timer is 10 hours, then the timer will expire in 20 hours.

During faults which disable charging, such as VIN OVP, BAT OVP, TSHUT, or TS faults, the timer is suspended. If the charging cycle is stopped and started again, the timer is reset (toggle of the TS pin restarts the timer).

The safety timer restarts counting when the charging cycle stops and restarts. This can occur as a result of the TS pin being toggled, the battery falling below the recharge threshold, or the input supply being toggled.

7.3.2.3 Battery Cold, Hot Temperature Qualification (TS Pin)

While charging, the device continuously monitors battery temperature by sensing the voltage at the TS pin. A negative temperature coefficient (NTC) thermistor should be connected between the TS and GND pins (recommend: 103AT-2). If temperature sensing is not required in the application, connect a fixed 10-k Ω resistor from the TS pin to GND to allow normal operation. Battery charging is allowed when the TS pin voltage falls between the V_{COLD} and V_{HOT} thresholds (typically 0°C to 45°C).

If the TS pin indicates battery temperature is outside this range, the device stops charging and enters the Standby state. Once battery temperature returns to normal conditions, charging resumes automatically.

In addition to battery temperature sensing, the TS pin can be used to disable the charger at any time by pulling TS voltage below V_{TS_ENZ} . The device disables the charger and consumes $I_{SD_IN_TS}$ from the input supply. In order to minimize quiescent current, the TS current source (I_{TS_BIAS}) is duty-cycled, with an on time of $I_{TS_DUTY_ON}$ and an off time of $I_{TS_DUTY_OFF}$. After the TS pin pulldown is released, the device may take up to $I_{TS_DUTY_OFF}$ to turn I_{TS_BIAS} back on. After the source is turned on, the TS pin voltage goes above V_{TS_EN} and reenables charger operation. The device treats this TS pin toggle as an input supply toggle, triggering a device power up from input source (see \ddagger 7.3.1).



7.3.3 Status Outputs (STAT)

7.3.3.1 Charging Status Indicator (STAT)

The device indicates the charging state on the open-drain STAT pin as listed in the following table. This pin can drive an LED.

表 7-3. STAT Pin States

CHARGING STATE	STAT PIN STATE
Charge completed (TMR_EXP), charger in Sleep mode or charge disabled	High
Charge in progress (including intermittent charge active)	Low
Fault (VIN OVP, BAT OVP, BAT OCP, or VSET, ISET, TMR pin short or open)	Blink at 1 Hz

7.3.4 Protection Features

The device closely monitors input and output voltages, as well as internal FET current and temperature for safe linear regulator operation.

7.3.4.1 Input Overvoltage Protection (VIN OVP)

If the voltage at the IN pin exceeds $V_{\text{IN_OV}}$, the device turns off, the safety timer suspends counting, and the device enters Standby mode. Once the $\overline{\text{IN}}$ voltage recovers to a normal level, the charge cycle and the safety timer automatically resume operation.

7.3.4.2 Output Overvoltage Protection (BAT OVP)

If the voltage at the OUT pin exceeds V_{OUT_OVP} , the device immediately stops charging, the safety timer suspends counting, and the device enters Standby mode. Once the OUT voltage recovers to a normal level, the charge cycle and the safety timer resume operation.

7.3.4.3 Output Overcurrent Protection (BAT OCP)

During normal operation, the OUT current should be regulated to the ISET programmed value. However, if a short circuit occurs on the ISET pin, the OUT current may rise to an unintended level. If the current at the OUT pin exceeds I_{OUT_OCP} , the device turns off after a deglitch, $t_{OUT_OCP_DGL}$, the safety timer resets the count, and the device remains latched off. An input supply or pin toggle is required to restart operation.

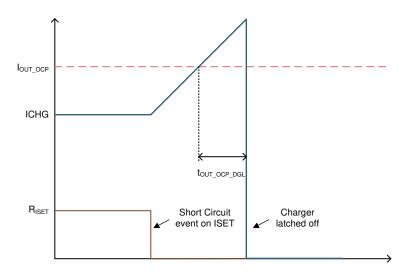


图 7-3. Overcurrent Protection



7.3.4.4 Thermal Regulation and Thermal Shutdown (TREG and TSHUT)

The device monitors its internal junction temperature (T_J) to avoid overheating and to limit the IC surface temperature. When the internal junction temperature exceeds the thermal regulation limit, the device automatically reduces the charge current to maintain the junction temperature at the thermal regulation limit (TREG). During thermal regulation, the safety timer runs at half the clock rate and the actual charging current is reduced below the programmed value on the ISET pin.

Additionally, the device has thermal shutdown to turn off the linear regulator when the IC junction temperature exceeds the TSHUT threshold. The charger resumes operation when the IC die temperature decreases below the TSHUT falling threshold.

7.4 Device Functional Modes

7.4.1 Shutdown or Undervoltage Lockout (UVLO)

The device is in the shutdown state if the IN pin voltage is less than V_{IN_LOWV} . The internal circuitry is powered down, all the pins are high impedance, and the device draws from the input supply. Once the IN voltage rises above the V_{IN_LOWV} threshold, the IC enters Sleep mode or Active mode depending on the OUT pin voltage.

7.4.2 Sleep Mode

The device is in Sleep mode when $V_{IN_LOWV} < V_{IN} < V_{OUT} + V_{SLEEPZ}$. The device waits for the input voltage to rise above $V_{OUT} + V_{SLEEPZ}$ to start operation.

7.4.3 Active Mode

The device is powered up and charges the battery when the TS pin is above V_{TS_ENZ} and the IN voltage ramps above both V_{IN_LOWV} and $V_{OUT} + V_{SLEEPZ}$. The device draws I_{Q_IN} from the supply to bias the internal circuitry. For details on the device power-up sequence, refer to $\ddagger 7.3.1$.

7.4.3.1 Standby Mode

The device is in Standby mode if a valid input supply is present and charge is terminated or if a recoverable fault is detected. The internal circuitry is partially biased, and the device continues to monitor for either V_{OUT} to drop below V_{RECHG} or the recoverable fault to be removed.

7.4.4 Fault Mode

The fault conditions are categorized into recoverable and nonrecoverable as follows:

- · Recoverable, from which the device should automatically recover once the fault condition is removed:
 - VIN OVP
 - BAT OVP
 - TS HOT
 - TS COLD
- Nonrecoverable, requiring pin or input supply toggle to resume operation:
 - BAT OCP
 - ISET pin short detected
 - Charge timer expires with V_{OUT} below V_{RECHG}



8 Application and Implementation

备注

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8.1 Application Information

A typical application consists of the device configured as a standalone battery charger for a 1-cell to 6-cell NiMH battery. The charge voltage and number of cells is configured using a pulldown resistor on the VSET pin. The charge current is configured using a pulldown resistor on the ISET pin. A battery thermistor may be connected to the TS pin to allow the device to monitor battery temperature and control charging. Pulling the TS pin below V_{TS_ENZ} disables the charging function. The safety timer is programmable through a pullown resistor on the TMR pin. Faults are indicated through the STAT pin.

8.2 Typical Applications

8.2.1 NiMH Charger Design Example

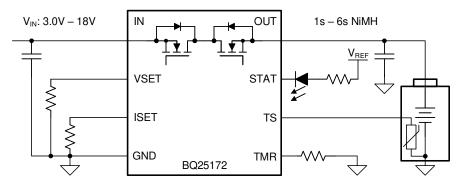


图 8-1. BQ25172 Simple Schematic

8.2.1.1 Design Requirements

The design requirements include the following:

- Input supply up to 18 V
- Battery: 4-cell NiMH, R_{VSET} = 11 k Ω
- Fast charge current: I_{CHG} = 30 mA
- Recharge voltage for intermittent cycles: V_{RECHG} = 1.33V x 4 = 5.32 V
- Charge safety timer: R_{TMR} = 8.2 kΩ, t_{SAFETY}: 16 hr
- TS Battery temperature sense = 10-k Ω NTC (103AT-2)
- TS can be pulled low to disable charging

8.2.1.2 Detailed Design Procedure

The regulation voltage is set via the VSET pin to 2s NiMH, the input voltage is 5 V and the charge current is programmed via the ISET pin to 500 mA.

$$R_{ISET} = [K_{ISET} / I_{CHG}]$$

from electrical characteristics table. . . K_{ISFT} = 300 $A\Omega$

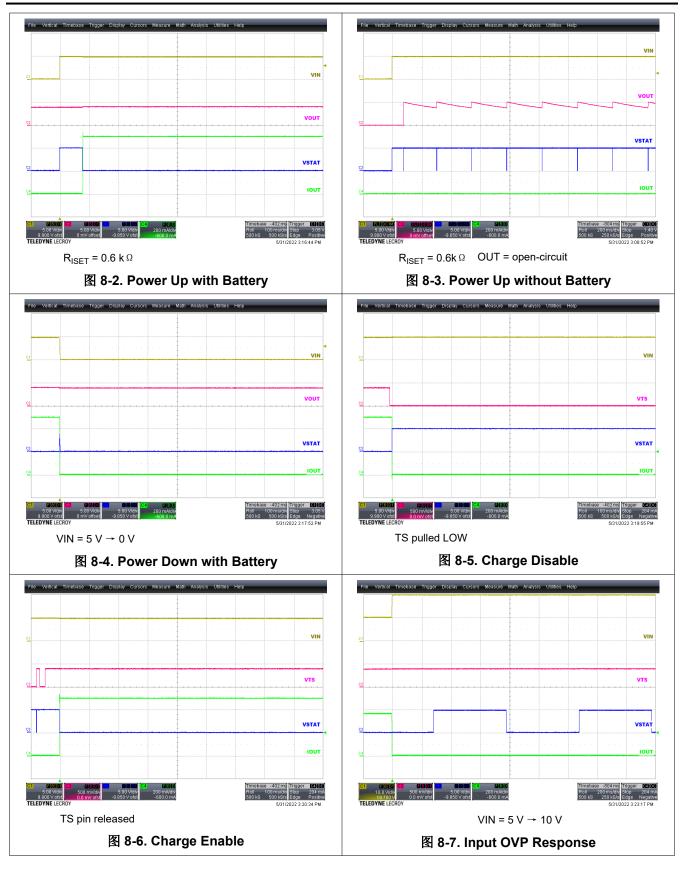
 $R_{ISFT} = [300 \text{ A}\Omega/0.5 \text{ A}] = 600 \Omega$

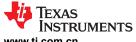
Selecting the closest 1% resistor standard value, use a 604- Ω resistor between ISET and GND, for an expected I_{CHG} 497 mA.

8.2.1.3 Application Curves

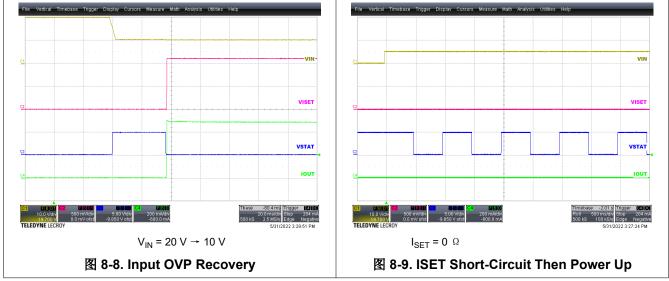
 $C_{IN} = 1 \mu F$, $C_{OUT} = 1 \mu F$, $V_{IN} = 5 V$, $V_{OUT} = 3.8 V$ (unless otherwise specified)













9 Power Supply Recommendations

The device is designed to operate from an input voltage supply range between 3 V and 18 V (tolerant up to 30 V) and current capability of at least the maximum designed charge current. If located more than a few inches from the IN and GND pins, a larger capacitor is recommended.

10 Layout

10.1 Layout Guidelines

To obtain optimal performance, the decoupling capacitor from the IN pin to the GND pin and the output filter capacitor from the OUT pin to the GND pin should be placed as close as possible to the device, with short trace runs to both IN, OUT, and GND.

- All low current GND connections should be kept separate from the high current charge or discharge paths
 from the battery. Use a single-point ground technique incorporating both the small signal ground path and the
 power ground path.
- The high current charge paths into the IN pin and from the OUT pin must be sized appropriately for the maximum charge current in order to avoid voltage drops in these traces.

10.2 Layout Example

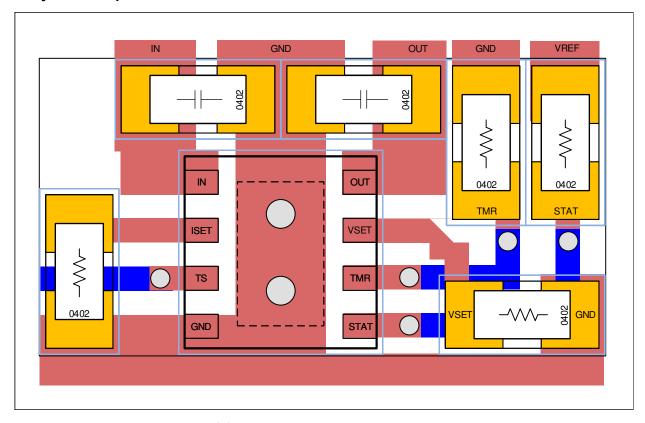


图 10-1. BQ25172 Layout Example

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11 Device and Documentation Support

11.1 Device Support

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11.6 术语表

TI 术语表

本术语表列出并解释了术语、首字母缩略词和定义。

ZHCSPT0 - JUNE 2022



12 Mechanical, Packaging, and Orderable Information

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
BQ25172DSGR	Active	Production	WSON (DSG) 8	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	B172
BQ25172DSGR.A	Active	Production	WSON (DSG) 8	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	B172

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

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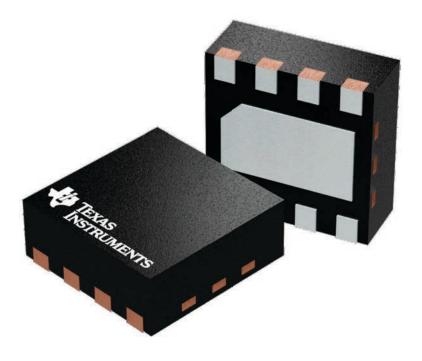
⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

2 x 2, 0.5 mm pitch

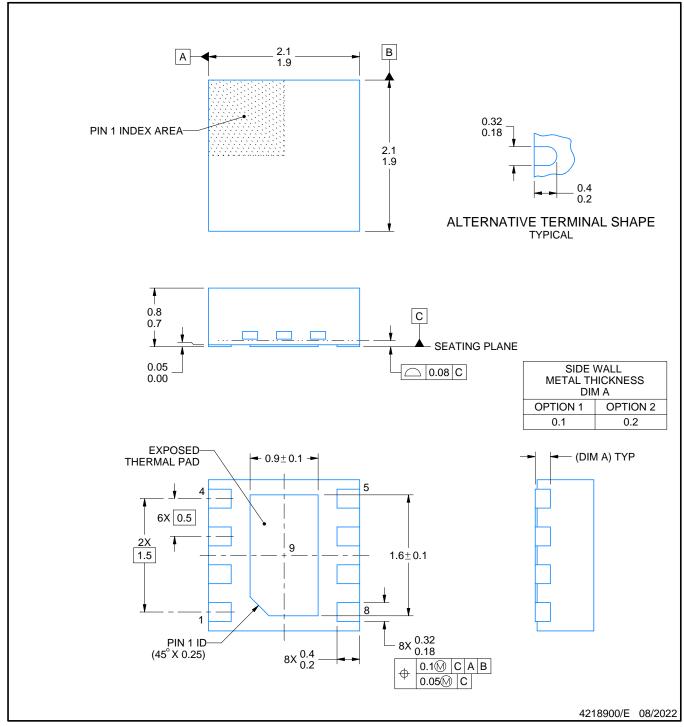
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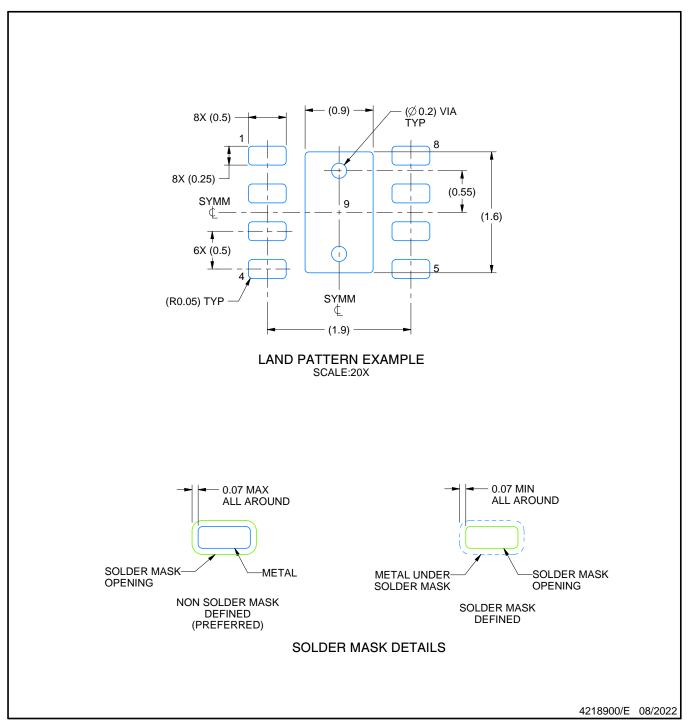


NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



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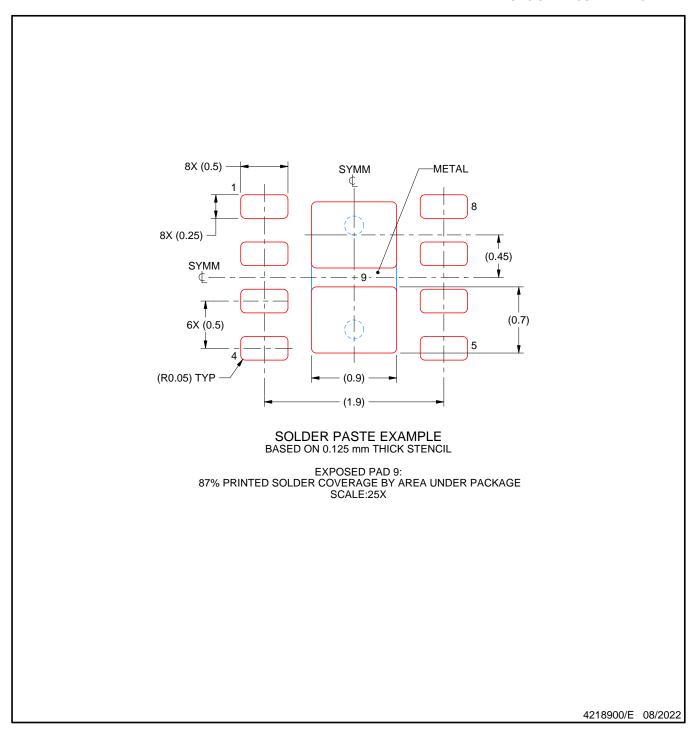


NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



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NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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